

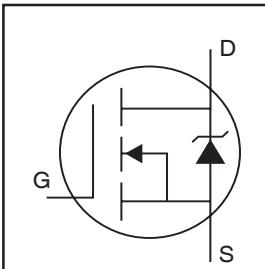
AUTOMOTIVE MOSFET

IRF3710ZPbF

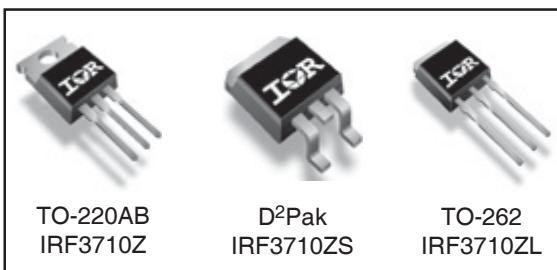
IRF3710ZSPbF

IRF3710ZLPbF

HEXFET® Power MOSFET



$V_{DSS} = 100V$
$R_{DS(on)} = 18m\Omega$
$I_D = 59A$



Features

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)	59	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (See Fig. 9)	42	
I_{DM}	Pulsed Drain Current ①	240	
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	160	W
	Linear Derating Factor	1.1	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	170	mJ
E_{AS} (tested)	Single Pulse Avalanche Energy Tested Value ⑦	200	
I_{AR}	Avalanche Current ①	See Fig.12a,12b,15,16	A
E_{AR}	Repetitive Avalanche Energy ⑥		mJ
T_J	Operating Junction and	-55 to + 175	°C
T_{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

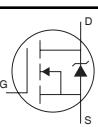
	Parameter	Typ.	Max.	Units
R_{0JC}	Junction-to-Case	—	0.92	°C/W
R_{0CS}	Case-to-Sink, Flat, Greased Surface	0.50	—	
R_{0JA}	Junction-to-Ambient	—	62	
R_{0JA}	Junction-to-Ambient (PCB Mount, steady state) ⑧	—	40	

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Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{GS} = 0\text{V}$, $I_D = 250\mu\text{A}$
$\Delta V_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.10	—	$\text{V}/^\circ\text{C}$	Reference to 25°C , $I_D = 1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	—	14	18	$\text{m}\Omega$	$V_{GS} = 10\text{V}$, $I_D = 35\text{A}$ ④
$V_{GS(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	35	—	—	S	$V_{DS} = 50\text{V}$, $I_D = 35\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	20	μA	$V_{DS} = 100\text{V}$, $V_{GS} = 0\text{V}$
		—	—	250		$V_{DS} = 100\text{V}$, $V_{GS} = 0\text{V}$, $T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{GS} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{GS} = -20\text{V}$
Q_g	Total Gate Charge	—	82	120	nC	$I_D = 35\text{A}$
Q_{gs}	Gate-to-Source Charge	—	19	28		$V_{DS} = 80\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	27	40		$V_{GS} = 10\text{V}$ ④
$t_{d(on)}$	Turn-On Delay Time	—	17	—	ns	$V_{DD} = 50\text{V}$
t_r	Rise Time	—	77	—		$I_D = 35\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	41	—		$R_G = 6.8\Omega$
t_f	Fall Time	—	56	—		$V_{GS} = 10\text{V}$ ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	2900	—		
C_{oss}	Output Capacitance	—	290	—	pF	$V_{GS} = 0\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	150	—		$V_{DS} = 25\text{V}$
C_{oss}	Output Capacitance	—	1130	—		$f = 1.0\text{MHz}$, See Fig. 5
C_{oss}	Output Capacitance	—	170	—		$V_{GS} = 0\text{V}$, $V_{DS} = 1.0\text{V}$, $f = 1.0\text{MHz}$
$C_{oss \text{ eff.}}$	Effective Output Capacitance	—	280	—		$V_{GS} = 0\text{V}$, $V_{DS} = 80\text{V}$, $f = 1.0\text{MHz}$
						$V_{GS} = 0\text{V}$, V_{DS} from 0 to 80V

Diode Characteristics

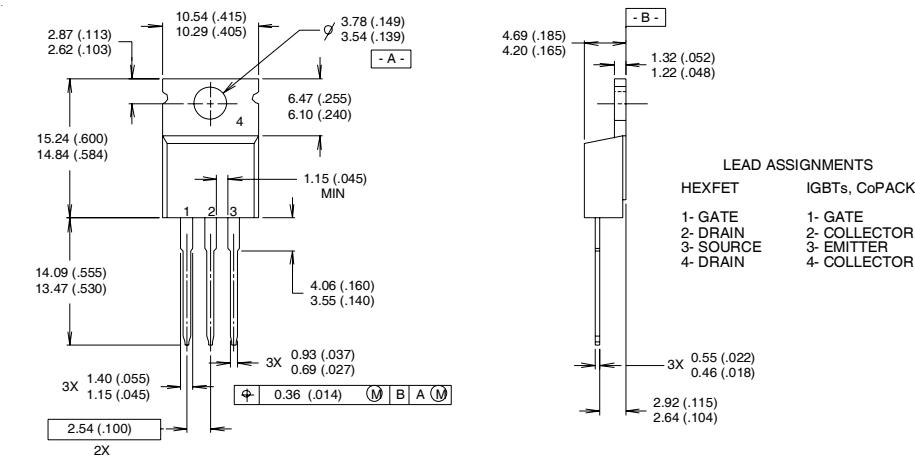
	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	59	A	MOSFET symbol showing the integral reverse p-n junction diode.
	Pulsed Source Current (Body Diode) ①	—	—	240		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$, $I_S = 35\text{A}$, $V_{GS} = 0\text{V}$ ④
	Reverse Recovery Time	—	50	75	ns	$T_J = 25^\circ\text{C}$, $I_F = 35\text{A}$, $V_{DD} = 25\text{V}$
Q_{rr}	Reverse Recovery Charge	—	100	160	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by $T_{J\text{max}}$, starting $T_J = 25^\circ\text{C}$, $L = 0.27\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 35\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value.
- ③ $I_{SD} \leq 35\text{A}$, $di/dt \leq 380\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 175^\circ\text{C}$.
- ④ Pulse width $\leq 1.0\text{ms}$; duty cycle $\leq 2\%$.
- ⑤ $C_{oss \text{ eff.}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} .
- ⑥ Limited by $T_{J\text{max}}$, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑦ This value determined from sample failure population. 100% tested to this value in production.
- ⑧ This is applied to D²Pak, when mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.

2 CONTROLLING DIMENSION : INCH

3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.

4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
 LOT CODE 1789
 ASSEMBLED ON WW 19, 1997
 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line
 position indicates "Lead-Free"

